International Rectifier

AUTOMOTIVE GRADE

AUIRFS4410Z AUIRFSL4410Z

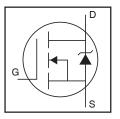
Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

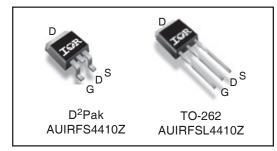
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

HEXFET® Power MOSFET



V _{DSS}		100V
R _{DS(on)}	typ.	7.2m Ω
	max.	9.0m Ω
I _D		97A



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	97	
I _D @ T _C = 100°C	Continuous Drain Current, VGS @ 10V	69	Α
I _{DM}	Pulsed Drain Current ①	390	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	230	W
	Linear Derating Factor	1.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	16	V/ns
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ②	242	mJ
I _{AR}	Avalanche Current	See Fig. 14, 15, 22a, 22b,	Α
E _{AR}	Repetitive Avalanche Energy ④		mJ
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		- °C
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.65	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D ² Pak ⑦		40	C/VV

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.12		V/°C	Reference to 25°C, I _D = 5mA①
R _{DS(on)}	Static Drain-to-Source On-Resistance		7.2	9.0	mΩ	$V_{GS} = 10V, I_D = 58A \oplus$
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	٧	$V_{DS} = V_{GS}$, $I_D = 150\mu A$
gfs	Forward Transconductance	140			S	$V_{DS} = 10V, I_{D} = 58A$
I _{DSS}	Drain-to-Source Leakage Current			20	μА	$V_{DS} = 100V, V_{GS} = 0V$
				250	μA	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	^	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V
R_G	Internal Gate Resistance		0.70		Ω	

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$\overline{Q_g}$	Total Gate Charge		83	120		$I_D = 58A$
Q_{gs}	Gate-to-Source Charge		19		nC	$V_{DS} = 50V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		27			V _{GS} = 10V ⊕
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		56			$I_D = 58A, V_{DS} = 0V, V_{GS} = 10V \oplus$
t _{d(on)}	Turn-On Delay Time		16			$V_{DD} = 65V$
t _r	Rise Time		52]	$I_D = 58A$
t _{d(off)}	Turn-Off Delay Time		43		ns	$R_G = 2.7\Omega$
t _f	Fall Time		57			V _{GS} = 10V ⊕
C _{iss}	Input Capacitance		4820			$V_{GS} = 0V$
C _{oss}	Output Capacitance		340			$V_{DS} = 50V$
C _{rss}	Reverse Transfer Capacitance		170		pF	f = 1.0MHz, See Fig.5
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		420			$V_{GS} = 0V$, $V_{DS} = 0V$ to $80V$ ©, See Fig.11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		690]	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions			
Is	Continuous Source Current			97		MOSFET symbol			
	(Body Diode)			97	,	showing the			
I _{SM}	Pulsed Source Current		390	000	000	200	1 000 A	^	integral reverse
	(Body Diode) ①			390		p-n junction diode.			
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 58A, V_{GS} = 0V \oplus$			
t _{rr}	Reverse Recovery Time		38	57	no	$T_J = 25^{\circ}C$ $V_R = 85V$,			
			46	69	ns	$T_J = 125$ °C $I_F = 58A$			
Q _{rr}	Reverse Recovery Charge		53	80		$T_J = 25^{\circ}C$ di/dt = 100A/ μ s ④			
			82	120	nC	$T_{\rm J} = 125^{\circ}{\rm C}$			
I _{RRM}	Reverse Recovery Current		2.5		Α	$T_{\rm J} = 25^{\circ}C$			
t _{on}	Forward Turn-On Time	Intrins	ic turn-	on time	is neg	ligible (turn-on is dominated by LS+LD)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 0.143mH R_G = 25 Ω , I_{AS} = 58A, V_{GS} =10V. Part not recommended for use above this value.
- $\label{eq:loss_def} \mbox{\Im} \ \ I_{SD} \leq 58A, \ di/dt \leq 610A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width \leq 400 μ s; duty cycle \leq 2%.

- $\ \ \,$ C $_{oss}$ eff. (ER) is a fixed capacitance that gives the same energy as C $_{oss}$ while V $_{DS}$ is rising from 0 to 80% V $_{DSS}.$
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- R_θ is measured at T_J approximately 90°C.



Qualification Information[†]

Qualification Level		Automotive (per AEC-Q101) ††				
		Comments: This part number(s) passe Automotive qualification. IR's Industrial an Consumer qualification level is granted be extension of the higher Automotive level.				
Maiatura Sanaitivity Laval		3L-D2 PAK	MSL1			
Woisture Seris	Moisture Sensitivity Level		N/A			
	Machine Model	Class M4(+/- 800V) ^{†††} AEC-Q101-002				
ESD	Human Body Model	Class H2(+/- 3000V) ^{†††} AEC-Q101-001				
	Charged Device Model	Class C5(+/- 2000V) ^{†††} AEC-Q101-005				
RoHS Compliant		Yes				

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.
- ††† Highest passing voltage

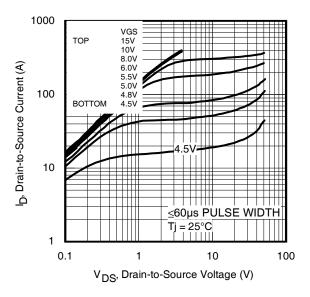


Fig 1. Typical Output Characteristics

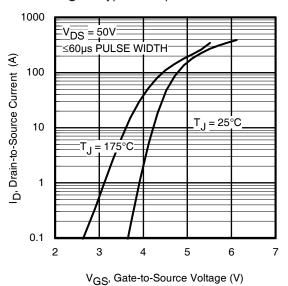


Fig 3. Typical Transfer Characteristics

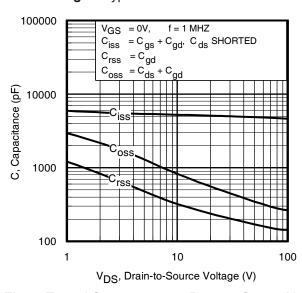


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

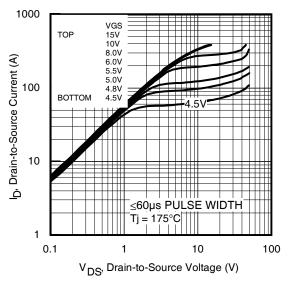


Fig 2. Typical Output Characteristics

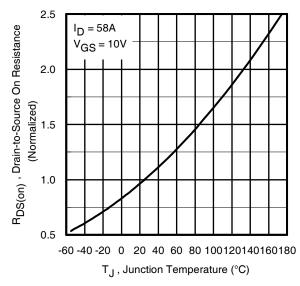


Fig 4. Normalized On-Resistance vs. Temperature

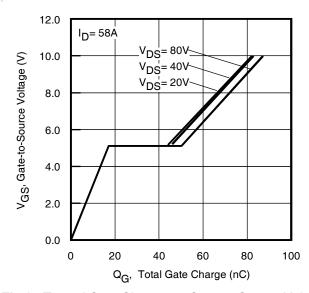


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

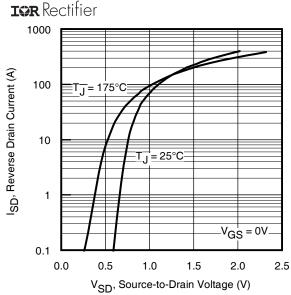


Fig 7. Typical Source-Drain Diode Forward Voltage

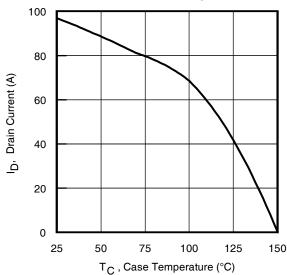
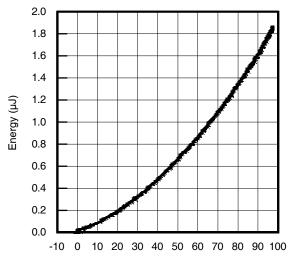


Fig 9. Maximum Drain Current vs.
Case Temperature



 $\label{eq:VDS} V_{DS,} \mbox{ Drain-to-Source Voltage (V)} \\ \mbox{ Fig 11. Typical C_{OSS} Stored Energy}$

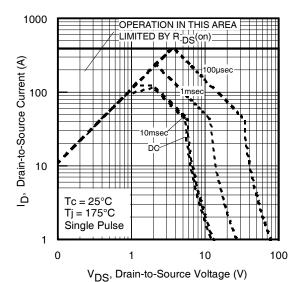


Fig 8. Maximum Safe Operating Area

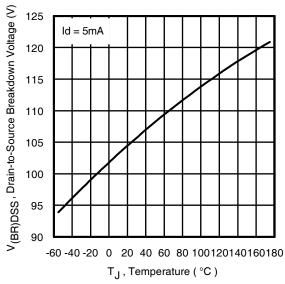


Fig 10. Drain-to-Source Breakdown Voltage

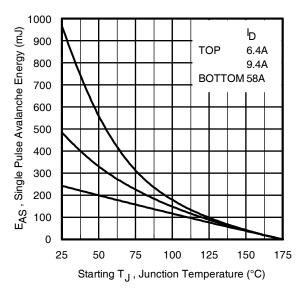


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

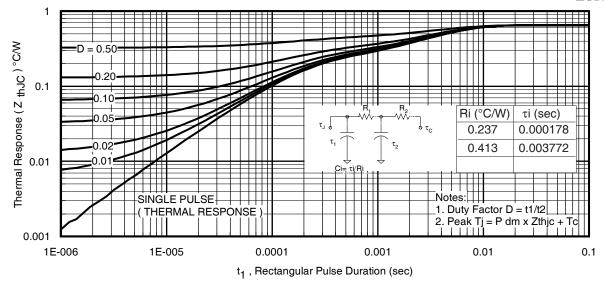


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

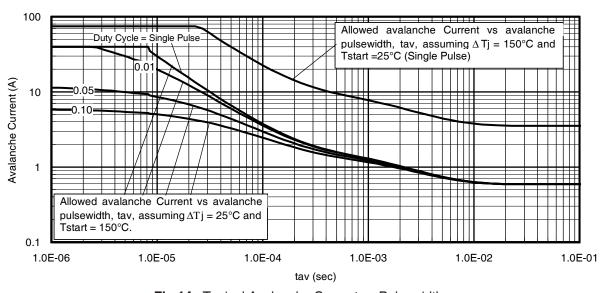


Fig 14. Typical Avalanche Current vs.Pulsewidth

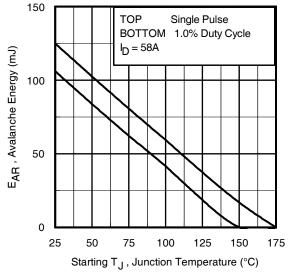


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

t_{av =} Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \triangle \text{T/ } Z_{thJC} \\ I_{av} &= 2\triangle \text{T/ [} 1.3 \cdot \text{BV} \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

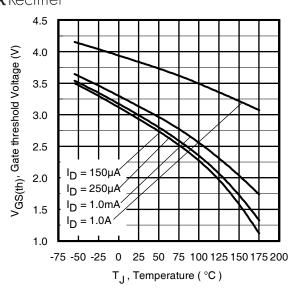


Fig 16. Threshold Voltage vs. Temperature

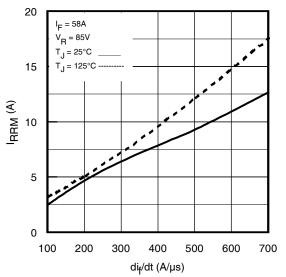


Fig. 18 - Typical Recovery Current vs. dif/dt

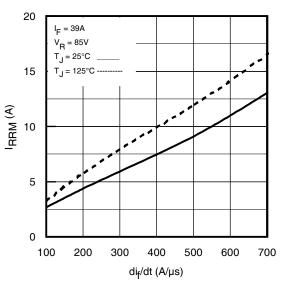


Fig. 17 - Typical Recovery Current vs. di_f/dt

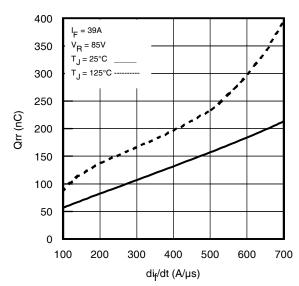


Fig. 19 - Typical Stored Charge vs. dif/dt

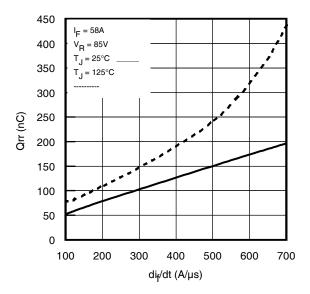


Fig. 20 - Typical Stored Charge vs. dif/dt

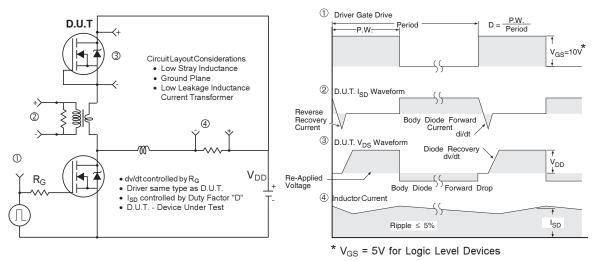


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

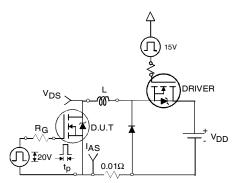


Fig 22a. Unclamped Inductive Test Circuit

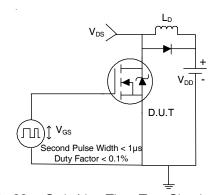


Fig 23a. Switching Time Test Circuit

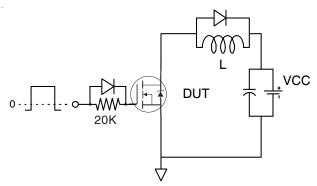


Fig 24a. Gate Charge Test Circuit

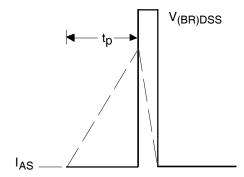


Fig 22b. Unclamped Inductive Waveforms

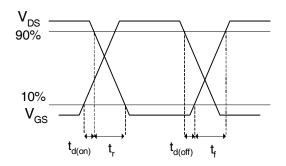


Fig 23b. Switching Time Waveforms

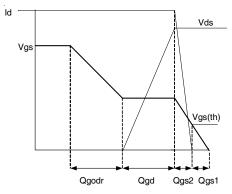
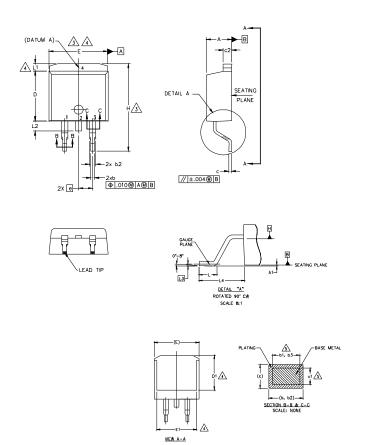


Fig 24b. Gate Charge Waveform

D²Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005*] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y			N		
M B O	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0,51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
ь2	1,14	1.78	.045	.070	
ь3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
Ε	9.65	10.67	.380	.420	3,4
E1	6,22	-	.245		4
e	2.54	BSC	.100	BSC	
Н	14.61	15,88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	1.27	1.78	-	.070	
L3	0.25	BSC	.010	BSC	
L4	4,78	5.28	.188	.208	

LEAD ASSIGNMENTS

HEXFET

1.- GATE 2, 4.- DRAIN 3.- SOURCE

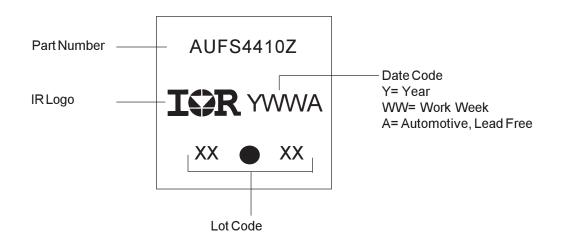
IGBTs, CoPACK

1.- GATE
2, 4.- COLLECTOR
3.- EMITTER

DIODES

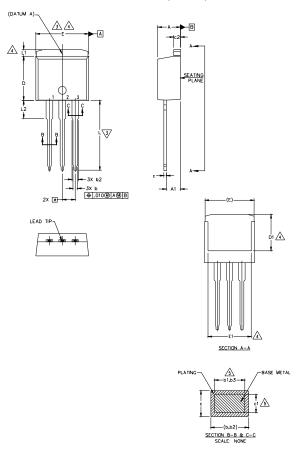
- 1.- ANODE *
 2, 4.- CATHODE
 3.- ANODE
- * PART DEPENDENT.

D²Pak Part Marking Information



TO-262 Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S						
S Y M		DIMEN	15	SIONS		Ň
B	MILLIMETERS			INC	N O T E S	
L	MIN.	MAX.	l	MIN.	MAX.	S
Α	4.06	4.83	l	.160	.190	
A1	2.03	3.02	l	.080	.119	
b	0.51	0.99	l	.020	.039	
ь1	0.51	0.89	l	.020	.035	5
b2	1,14	1.78	l	.045	.070	
b3	1.14	1.73	l	.045	.068	5
С	0.38	0.74	l	.015	.029	
с1	0.38	0.58	l	.015	.023	5
c2	1.14	1.65	l	.045	.065	
D	8,38	9,65	l	.330	.380	3
D1	6.86	-	l	.270	_	4
Ε	9.65	10.67	l	.380	.420	3,4
E1	6,22	-	l	.245		4
e	2.54	BSC		.100	BSC	
L	13.46	14.10	lĺ	.530	.555	
L1	-	1.65	l	-	.065	4
L2	3.56	3,71	I	.140	.146	

LEAD ASSIGNMENTS

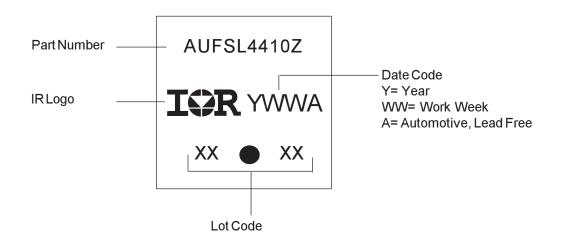
HEXFET

- 1.- GATE 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

IGBTs. CoPACK

- 1 GATE
- 2.- COLLECTOR
 3.- EMITTER
 4.- COLLECTOR

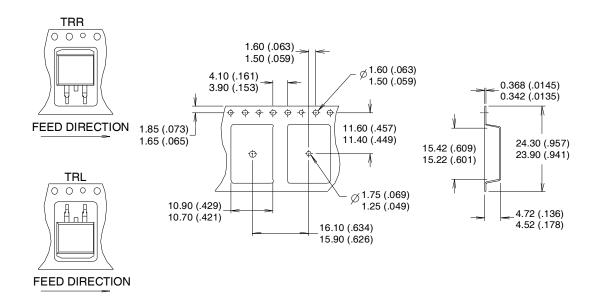
TO-262 Part Marking Information

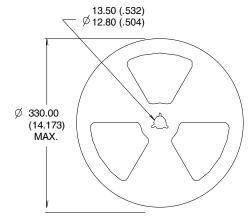


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak (TO-263AB) Tape & Reel Information

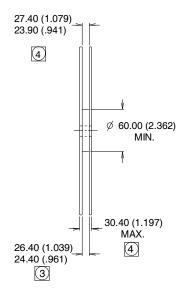
Dimensions are shown in millimeters (inches)







- COMFORMS TO EIA-418.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.



Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRFSL4410Z	TO-262	Tube	50	AUIRFSL4410Z
AUIRFS4410Z	D2Pak	Tube	50	AUIRFS4410Z
		Tape and Reel Left	800	AUIRFS4410ZTRL
		Tape and Reel Right	800	AUIRFS4410ZTRR



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WORLD HEADQUARTERS:

101 N. Sepulveda Blvd., El Segundo, California 90245

Tel: (310) 252-7105